

Test report No. : 12717479H-C-R1
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Issued date : May 23, 2019
FCC ID : WAZSKESAD02

RADIO TEST REPORT

Test Report No.: 12717479H-C-R1

Applicant : Mitsubishi Electric Corporation Himeji works

Type of Equipment : Smart Keyless System Hand Unit

Model No. : SKESAD-02

FCC ID : WAZSKESAD02

Test regulation : FCC Part 15 Subpart C: 2018

Test Result : Complied (Refer to SECTION 3.2)

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.

- 2. The results in this report apply only to the sample tested.
- 3. This sample tested is in compliance with above regulation.
- 4. The test results in this report are traceable to the national or international standards.
- 5. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
- 6. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
- 7. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
- 8. The information provided from the customer for this report is identified in SECTION 1.
- 9. This report is a revised version of 12717479H-C. 12717479H-C is replaced with this report.

Date of test:

Representative test engineer:

February 6 to 17, 2019

Akihiko Maeda

Engineer

Consumer Technology Division

Approved by:

Motoya Imura

Leader

Consumer Technology Division



This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation. *As for the range of Accreditation in NVLAP, you may refer to the WEB address,

http://japan.ul.com/resources/emc accredited/

The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.

There is no testing item of "Non-accreditation".

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REVISION HISTORY

Original Test Report No.: 12717479H-C

Revision	Test report No.	Date	Page revised	Contents
-	12717479H-C	March 14, 2019	-	-
(Original)		,, 2019		
1	12717479H-C-R1	May 23, 2019	P.5	Correction of Worst margin of Electric Field
				Strength of Fundamental Emission in Clause 3.2;
				From QP to PK with Duty factor
1	12717479H-C-R1	May 23, 2019	P.15	Correction of Plot data in Radiated Spurious
		,		Emission test

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CONTENTS PAGE SECTION 1: SECTION 2: SECTION 3: SECTION 4:

Operation of E.U.T. during testing......8 Radiated emission (Electric Field Strength of Fundamental and Spurious Emission). 9 **SECTION 5: SECTION 6: SECTION 7:** -20dB and 99% Occupied Bandwidth 16 **APPENDIX 2:** Test instruments _______18 **APPENDIX 3:**

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SECTION 1: Customer information

Company Name : Mitsubishi Electric Corporation Himeji works Address : 840 Chiyoda-machi, Himeji, Hyogo 670-8677, Japan

Telephone Number : +81-79-298-9580 Facsimile Number : +81-79-298-9929 Contact Person : Shinichi Furuta

The information provided from the customer is as follows;

- Applicant, Type of Equipment, Model No. on the cover and other relevant pages
- SECTION 1: Customer information
- SECTION 2: Equipment under test (E.U.T.)
- SECTION 4: Operation of E.U.T. during testing
- * The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Smart Keyless System Hand Unit

Model No. : SKESAD-02

Serial No. : Refer to Section 4, Clause 4.2

Rating : DC 3.0 V Receipt Date of Sample : February 4, 2019

(Information from test lab.)

Country of Mass-production : Japan

Condition of EUT : Engineering prototype

(Not for Sale: This sample is equivalent to mass-produced items.)

Modification of EUT : No Modification by the test lab

2.2 Product Description

Model: SKESAD-02 (referred to as the EUT in this report) is a Smart Keyless System Hand Unit.

Radio Specification

RF Part

Equipment Type : Transmitter
Type of modulation : FSK
Frequency of operation : 315 MHz

Other clock frequency :

Antenna Type : Patter antenna Clock frequency : 9.84375 MHz

LF Part *

Type of Receiver : Receiver
Frequency of operation : 125 kHz

Other clock frequency : 615.2 kHz (CPU)

Intermediate frequency : -

Antenna Type : Inductive

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^{*} The test of receiver part was performed separately from this test report, and the conformability is confirmed. LF Part test report No. 12717479H-D (FCC15B).

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C

FCC Part 15 final revised on March 12, 2018 and effective April 11, 2018

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators

Section 15.231 Periodic operation in the band 40.66-40.70 MHz and above 70 MHz.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.10:2013 6 Standard test methods IC: RSS-Gen 8.8	IC: RSS-Gen 8.8	N/A *1)	N/A	-
Automatically Deactivate	FCC: ANSI C63.10:2013 6 Standard test methods IC: -	FCC: Section 15.231(a)(1) IC: RSS-210 A1.1	N/A	Complied a)	Radiated
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.10:2013 6 Standard test methods IC: RSS-Gen 6.12	IC: RSS-210 A1.2	3.5 dB 315.000 MHz Horizontal, PK with Duty Factor	Complied#	Radiated
Electric Field Strength of Spurious Emission	FCC: ANSI C63.10:2013 6 Standard test methods IC: RSS-Gen 6.13	FCC: Section 15.205 Section 15.209 Section 15.231(b) IC: RSS-210 A1.2, 4.4 RSS-Gen 8.9	2.3 dB 2835.000 MHz Vertical PK with Duty Factor	Complied#	Radiated
-20dB Bandwidth	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(c) IC: Reference data	N/A	Complied c)	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

- a) Refer to APPENDIX 1 (data of Automatically deactivate)
- b) Refer to APPENDIX 1 (data of Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission))
- c) Refer to APPENDIX 1 (data of -20dB and 99% Occupied Bandwidth)

Symbols:

Complied The data of this test item has enough margin, more than the measurement uncertainty.

Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.

FCC 15.31 (e)

This test was performed with the New Battery (DC 3.0 V) during the tests. Therefore, the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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^{*} Also the EUT complies with FCC Part 15 Subpart B.

^{*1)} The test is not applicable since the EUT does not have AC Mains.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99 % Occupied Bandwidth	IC: RSS-Gen 6.7	IC: RSS-210 A1.3	N/A	-	Radiated
Note: UL Japan, Inc.'s EMI	Work Procedures No. 13-E	M-W0420 and 13-EM-W04	122.		
1					

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the following results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor k = 2.

Test distance	Radiated emission (+/-)	
	9 kHz to 30 MHz	
3 m	3.3 dB	
10 m	3.2 dB	

^{*}Measurement distance

	Radiated emission (Below 1 GHz)					
Polarity	(3 m	*)(+/-)	(10 m*)(+/-)			
	30 MHz to 200 MHz	200 MHz to 1000 MHz	30 MHz to 200 MHz	200 MHz to 1000 MHz		
Horizontal	4.8 dB	5.2 dB	4.8 dB	5.0 dB		
Vertical	5.0 dB	6.3 dB	4.9 dB	5.0 dB		

Radiated emission (Above 1 GHz)						
(3 m*)(+/-)		(1 m*)(+/-)		(10 m*)(+/-)		
1 GHz to 6 GHz	6 GHz to 18 GHz	10 GHz to 26.5 GHz	26.5 GHz to 40 GHz	1 GHz to 18 GHz		
5.0 dB	5.3 dB	5.8 dB	5.8 dB	5.2 dB		

^{*} Measurement distance

Automatically Deactivate
0.10 %

Bandwidth
0.96 %

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3.5 Test Location

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NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967

Test site	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measuremen t distance
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	_
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.6 shielded room	-	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	-	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	-	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	-	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	-	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	-	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

^{*} Size of vertical conducting plane (for Conducted Emission test): $2.0 \text{ m} \times 2.0 \text{ m}$ for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

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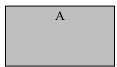
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SECTION 4: Operation of E.U.T. during testing

4.1 **Operating Mode(s)**

Test Item*	Mode			
Automatically Deactivate	1) Normal use mode			
Electric Field Strength of Fundamental Emission	2) Transmitting mode (Tx) 315 MHz			
Electric Field Strength of Spurious Emission				
-20 dB & 99 % Occupied Bandwidth				
Duty Cycle				
* The system was configured in typical fashion (as a user would normally use it) for testing.				
End users cannot change the settings of the output por	wer of the product.			

4.2 Configuration and peripherals



Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Smart Keyless System	SKESAD-02	20190131-T1 (No.1)	Mitsubishi Electric	EUT
	Hand Unit		*1)	Corporation Himeji works	
			20190131-T2 (No.2)	_	
			*2)		

^{*1)} Used for other tests except for Normal use mode.

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^{*} Setup was taken into consideration and test data was taken under worse case conditions.

^{*2)} Used for Normal use mode only

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SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

[For below 30 MHz]

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

[For 30 MHz to 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver / spectrum analyzer.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

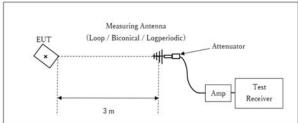
	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz	Above 1 GHz
Detector Type	Peak	Peak	Peak	Peak	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	200 Hz	200 Hz	9.0 kHz	9.0 kHz	120 kHz	PK: S/A: RBW 1 MHz, VBW: 3 MHz

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[Test Setup]

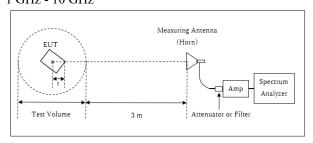
Below 1 GHz



× : Center of turn table

Test Distance: 3 m

1 GHz - 10 GHz



- Distance Factor: $20 \times \log (3.7 \text{ m} / 3.0 \text{ m}) = 1.82 \text{ dB}$ * Test Distance: (3 + Test Volume / 2) - r = 3.7 m
- Test Volume: 1.5 m

(Test Volume has been calibrated based on CISPR 16-1-4.)

r = 0.05 m

- r : Radius of an outer periphery of EUT
- ×: Center of turn table
- The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

Noise levels of all the frequencies were measured at the position.

*The result is rounded off to the second decimal place, so some differences might be observed.

Measurement range : 9 kHz - 3.2 GHz Test data : APPENDIX

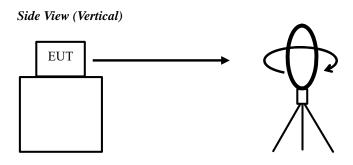
Test result : Pass

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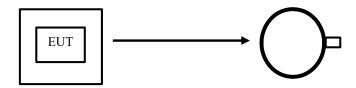
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Figure 1: Direction of the Loop Antenna



.....

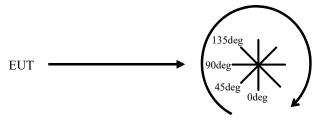
Top View (Horizontal)



Antenna was not rotated.

.....

Top View (Vertical)



Front side: 0 deg.

Forward direction: clockwise

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SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX

Test result : Pass

SECTION 7: -20 dB and 99 % Occupied Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used			
20 dB Bandwidth	500 kHz	5.1 kHz	16 kHz	Auto	Peak	Max Hold	Spectrum Analyzer			
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer			
Peak hold was appli	Peak hold was applied as Worst-case measurement.									

Test data : APPENDIX
Test result : Pass

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APPENDIX 1: Test data

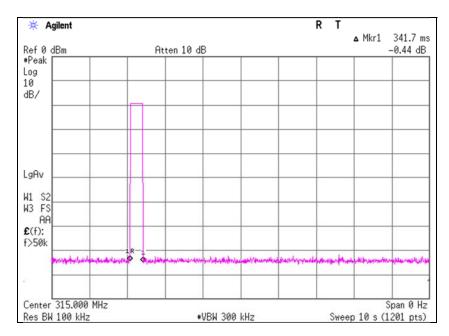
Automatically deactivate

Report No. 12717479H Test place Ise EMC Lab.

Semi Anechoic Chamber No.4

Date February 17, 2019
Temperature / Humidity 20 deg. C / 51 % RH
Engineer Akihiko Maeda
Mode Mode 1

Time of	Limit	Result
Transmitting		
[sec]	[sec]	
0.3417	5.00	Pass



^{*} The EUT transmits UHF when LF signal is received from a car or a button on the EUT is pressed. In both cases, the UHF transmission is stopped within 5 seconds. So the test was performed by a button-pressed operation as the worst case.

Please refer to the "Theory of Operation" for details.

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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Report No. 12717479H Test place Ise EMC Lab.

Semi Anechoic Chamber No.2 No.2

Date February 6, 2019 February 7, 2019
Temperature / Humidity 23 deg. C / 45 % RH 23 deg. C / 48 % RH
Engineer Akihiko Maeda (Below 1 GHz) February 7, 2019
23 deg. C / 48 % RH
Akihiko Maeda (Above 1 GHz)

Mode 2

OP or PK

QIUIIK	ZI OI I K												
Frequency	Detector	Rea	ding	Ant	Loss	Gain	Duty	Res	sult	Limit	Ma	rgin	Remark
		[dB	uV]	Factor			Factor	[dBu	V/m]		[d	B]	Inside or Outside
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	of Restricted Bands
315.000	PK	78.5	76.8	13.9	9.0	29.3	-	72.1	70.4	95.6	23.5	25.2	Carrier
630.000	PK	35.4	35.7	19.3	10.3	29.6	-	35.5	35.8	75.6	40.2	39.9	Outside
945.000	PK	32.0	32.0	21.9	11.5	27.8	-	37.6	37.6	75.6	38.0	38.0	Outside
1260.000	PK	48.3	46.7	25.3	5.5	35.1	-	44.0	42.4	75.6	31.6	33.2	Outside
1575.000	PK	51.7	48.0	25.4	5.0	34.8	-	47.3	43.6	73.9	26.6	30.3	Inside
1890.000	PK	50.6	49.7	25.8	5.0	34.5	-	46.9	46.0	75.6	28.7	29.6	Outside
2205.000	PK	47.6	47.0	27.9	5.1	34.3	-	46.3	45.6	73.9	27.7	28.3	Inside
2520.000	PK	48.9	48.8	27.8	5.2	34.2	-	47.7	47.5	75.6	27.9	28.1	Outside
2835.000	PK	51.3	52.0	28.4	5.3	34.1	-	50.9	51.6	73.9	23.0	22.3	Inside
3150.000	PK	51.1	50.1	28.6	5.4	34.0	-	51.1	50.1	75.6	24.5	25.5	Outside

PK with Duty factor

TIK With Duty it	K with Duty factor												
Frequency	Detector	Rea	ding	Ant	Loss	Gain	Duty	Res	sult	Limit	Ma	rgin	Remark
		[dB	uV]	Factor			Factor	[dBu	V/m]		[d	B]	
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	
315.000	PK	78.5	76.8	13.9	9.0	29.3	0.0	72.1	70.4	75.6	3.5	5.2	Carrier
630.000	PK	35.4	35.7	19.3	10.3	29.6	0.0	35.5	35.8	55.6	20.2	19.9	Outside
945.000	PK	32.0	32.0	21.9	11.5	27.8	0.0	37.6	37.6	55.6	18.0	18.0	Outside
1260.000	PK	48.3	46.7	25.3	5.5	35.1	0.0	44.0	42.4	55.6	11.6	13.2	Outside
1575.000	PK	51.7	48.0	25.4	5.0	34.8	0.0	47.3	43.6	53.9	6.6	10.3	Inside
1890.000	PK	50.6	49.7	25.8	5.0	34.5	0.0	46.9	46.0	55.6	8.7	9.6	Outside
2205.000	PK	47.6	47.0	27.9	5.1	34.3	0.0	46.3	45.6	53.9	7.7	8.3	Inside
2520.000	PK	48.9	48.8	27.8	5.2	34.2	0.0	47.7	47.5	55.6	7.9	8.1	Outside
2835.000	PK	51.3	52.0	28.4	5.3	34.1	0.0	50.9	51.6	53.9	3.0	2.3	Inside
3150.000	PK	51.1	50.1	28.6	5.4	34.0	0.0	51.1	50.1	55.6	4.5	5.5	Outside

Sample calculation:

Result of PK = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1GHz) + Distance factor (above 1 GHz)} - Gain (Amplifier)

Result of PK with Duty factor = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1 GHz) + Distance factor (above 1 GHz)} - Gain (Amplifier)

For above 1GHz: Distance Factor: $20 \times \log (3.7 \text{ m/} 3.0 \text{ m}) = 1.82 \text{ dB}$

Since the peak emission result satisfied the average limit, duty factor was omitted.

Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100% as worst.

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^{*}Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

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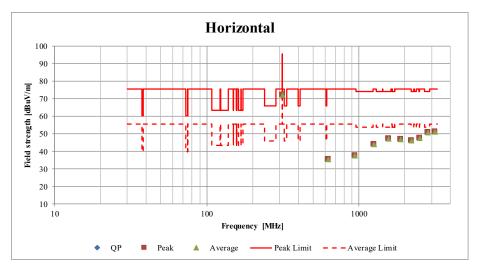
Radiated Spurious Emission (Plot data, Worst case)

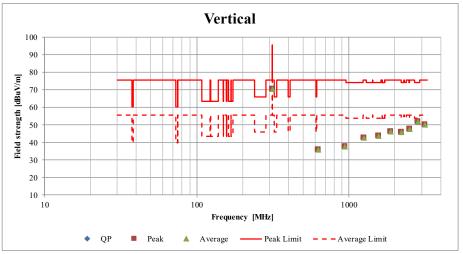
Report No. 12717479H Test place Ise EMC Lab.

Semi Anechoic Chamber No.2 No.2

Date February 6, 2019 February 7, 2019
Temperature / Humidity 23 deg. C / 45 % RH 23 deg. C / 48 % RH
Engineer Akihiko Maeda (Below 1 GHz) February 7, 2019
Akihiko Maeda (Akihiko Maeda (Above 1 GHz)

Mode 2





^{*}These plots data contains sufficient number to show the trend of characteristic features for EUT.

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-20dB and 99% Occupied Bandwidth

Report No. 12717479H Test place Ise EMC Lab.

Semi Anechoic Chamber No.4

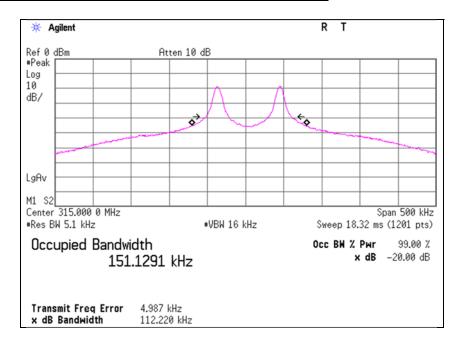
Date February 17, 2019
Temperature / Humidity 20 deg. C / 51 % RH
Engineer Akihiko Maeda
Mode Mode 2

Bandwidth Limit : Fundamental Frequency 315.00 MHz x 0.25% = 787.50 kHz

^{*} The above limit was calculated from more stringent nominal frequency.

-20dB Bandwidth	Bandwidth Limit	Result
[kHz]	[kHz]	
112.220	787.50	Pass

99% Occupied Bandwidth	Bandwidth Limit	Result
[kHz]	[kHz]	
151.1291	787.50	Pass



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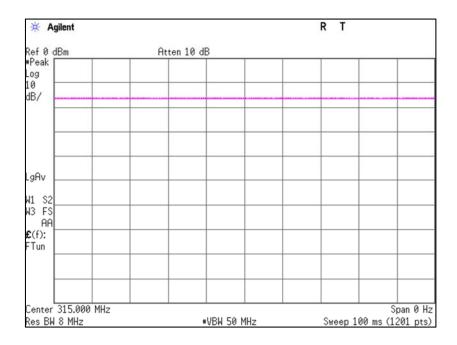
Duty Cycle

Report No. 12717479H Test place Ise EMC Lab.

Semi Anechoic Chamber No.4

Date February 17, 2019
Temperature / Humidity 20 deg. C / 51 % RH
Engineer Akihiko Maeda

Mode 2



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APPENDIX 2: Test instruments

Test Instruments

Test	LIMS ID	Description	Manufacturer	Model	Serial	Last	Calibration	Cal Int
item						Calibration Date	Due Date	
RE	141950	EMI Test Receiver	Rohde & Schwarz	ESU26	100412	06/15/2018	06/30/2019	12
RE	141152	EMI measurement program	TSJ	TEPTO-DV	-	-	-	_
RE	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	08/06/2018	08/31/2019	12
RE	141203	Attenuator(6dB)	Weinschel Corp	2	BK7970	11/05/2018	11/30/2019	12
RE	141317	Coaxial Cable	Fujikura/Agilent	-	-	02/23/2018	02/28/2019	12
RE	141265	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	911B-190	05/31/2018	05/31/2019	12
RE	141578	Pre Amplifier	AGILENT	8447D	2944A10845	09/19/2018	09/30/2019	12
RE	141427	Biconical Antenna	Schwarzbeck	VHA9103B	8031	05/31/2018	05/31/2019	12
RE	141297	High Pass Filter(1.1-10GHz)	TOKYO KEIKI	TF219CD1	1001	01/10/2019	01/31/2020	12
RE	141579	Pre Amplifier	AGILENT	8449B	3008A02142	01/21/2019	01/31/2020	12
RE	141393	Microwave Cable	Junkosha	MWX221	1604S254(1 m) / 1608S088(5 m)	08/08/2018	08/31/2019	12
RE	141512	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	254	06/06/2018	06/30/2019	12
RE	142228	Measure	KOMELON	KMC-36	-	-	-	-
RE	141542	Digital Tester	Fluke Corporation	FLUKE 26-3	78030611	08/21/2018	08/31/2019	12
RE	141556	Thermo-Hygrometer	CUSTOM	CTH-201	0003	12/05/2018	12/31/2019	12
RE	142004	AC2_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-06902	06/29/2018	06/30/2020	24
RE	142006	AC2_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-06902	04/01/2018	04/29/2019	12
RE	142645	Loop Antenna	UL Japan	-	-	-	-	_

^{*}Hyphens for Last Calibration Date, Calibration Due Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test item:

RE: Radiated emission, 99 % Occupied Bandwidth, -20 dB bandwidth, Automatically deactivate and Duty cycle tests

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